

Notice of References Cited		Application/Control No. 10/653,829	Applicant(s)/Patent Under Reexamination CULLICK ET AL.	
		Examiner CUONG V. LUU	Art Unit 2128	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,103,920 A	04-1992	Patton, Bob J.	175/45
*	B	US-5,838,634 A	11-1998	Jones et al.	367/73
*	C	US-5,992,519 A	11-1999	Ramakrishnan et al.	166/250.15
*	D	US-5,980,096 A	11-1999	Thalhammer-Reyero, Cristina	707/100
*	E	US-6,106,561 A	08-2000	Farmer, Christopher L.	703/10
*	F	US-6,266,619 B1	07-2001	Thomas et al.	702/13
*	G	US-2002/0013687 A1	01-2002	Ortoleva, Peter J.	703/10
*	H	US-2002/0016679 A1	02-2002	Thomas et al.	702/14
*	I	US-6,356,844 B2	03-2002	Thomas et al.	702/12
*	J	US-2002/0053430 A1	05-2002	Curtis et al.	166/250.01
*	K	US-2002/0067373 A1	06-2002	Roe et al.	345/762
*	L	US-2002/0099505 A1	07-2002	Thomas et al.	702/12
*	M	US-2002/0120429 A1	08-2002	Ortoleva, Peter J.	703/2

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	P					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No. 10/653,829	Applicant(s)/Patent Under Reexamination CULLICK ET AL.	
		Examiner CUONG V. LUU	Art Unit 2128	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0169785 A1	11-2002	Netemeyer et al.	707/103.00R
*	B	US-2002/0177955 A1	11-2002	Jalali et al.	702/9
*	C	US-2002/0169589 A1	11-2002	Banki et al.	703/15
*	D	US-2003/0033184 A1	02-2003	Benbassat et al.	705/8
*	E	US-6,549,854 B1	04-2003	Malinverno et al.	702/16
*	F	US-2003/0209348 A1	11-2003	Ward et al.	166/256
*	G	US-2003/0220775 A1	11-2003	Jourdan et al.	703/2
*	H	US-2003/0205378 A1	11-2003	Wellington et al.	166/302
*	I	US-2004/0034465 A1	02-2004	Spiesberger, John Louis	701/200
*	J	US-2004/0020642 A1	02-2004	Vinegar et al.	166/245
*	K	US-6,715,551 B2	04-2004	Curtis et al.	166/250.16
*	L	US-2004/0122640 A1	06-2004	Dusterhoff, Ronald G.	703/010
*	M	US-2004/0174357 A1	09-2004	Cheung et al.	345/419

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	R					
	O					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited			Application/Control No. 10/653,829	Applicant(s)/Patent Under Reexamination CULLICK ET AL.	
			Examiner CUONG V. LUU	Art Unit 2128	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0181422 A1	09-2004	Brand, Robert J.	705/001
*	B	US-2005/0015231 A1	01-2005	Edwards et al.	703/010
*	C	US-6,853,921 B2	02-2005	Thomas et al.	702/14
*	D	US-6,980,940 B1	12-2005	Gurpinar et al.	703/10
*	E	US-7,010,558 B2	03-2006	Morris, Chris	708/409
*	F	US-7,047,171 B1	05-2006	Sproch, Norman K.	703/12
*	G	US-7,096,172 B2	08-2006	Colvin et al.	703/10
*	H	US-7,277,836 B2	10-2007	Netemeyer et al.	703/6
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	R					
	O					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.